



ITW

**PATENT APPLICATION**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of

Docket No: Q76787

Takeshi SHIMIZU

Allowed: September 30, 2005

Appln. No.: 10/633,716

Group Art Unit: 1756

Confirmation No.: 5699

Examiner: Christopher G. Young

Filed: August 05, 2003

For: METHOD FOR MEASURING GAP BETWEEN MASK AND SUBSTRATE OF  
DISPLAY PANEL

**REQUEST FOR INITIALED PTO/SB/08**

**MAIL STOP ISSUE FEE**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

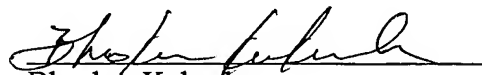
Applicant filed an Information Disclosure Statement on July 28, 2005 for the present application. The Examiner has not returned the initialed PTO/SB/08 filed with the Information Disclosure Statement.

For the Examiner's convenience, copies of the Information Disclosure Statement under 37 C.F.R. §§ 1.97 and 1.98, PTO/SB/08, Statement Under 37 C.F.R. § 1.97(e), and cited reference, together with a copy of the OIPE date-stamped filing receipt are attached herewith.

The Examiner is respectfully requested to return the initialed PTO/SB/08, indicating that the cited reference has been considered by the Examiner.

Respectfully submitted,

SUGHRUE MION, PLLC  
Telephone: (202) 293-7060  
Facsimile: (202) 293-7860

  
Bhaskar Kakarla  
Registration No. 54,627

WASHINGTON OFFICE

**23373**

CUSTOMER NUMBER

Date: November 17, 2005



**FILING RECEIPT**

**PLEASE DATE STAMP AND RETURN TO US - BOX 235X**



In re application of

Takeshi SHIMIZU

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Examiner: Christopher G. Young

Filed: August 05, 2003

For: METHOD FOR MEASURING GAP BETWEEN MASK AND SUBSTRATE OF DISPLAY  
PANEL

**PAPER(S) FILED ENTITLED:**

1. Information Disclosure Statement (with a copy of Communication from a foreign patent office, 1 reference and PTO/SB/08 A & B (modified)).
2. Statement Under 37 C.F.R. § 1.97(e).

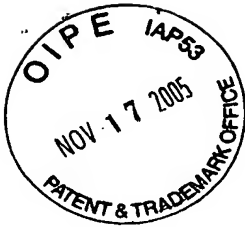
SUGHRUE MION, PLLC  
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DOCKET NO.: Q76787  
ATTORNEY/SEC: KGH/BK:db  
Date Filed: July 28, 2005

WASHINGTON OFFICE

**23373**

CUSTOMER NUMBER



**PATENT APPLICATION**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of

Docket No: Q76787

**DOCKETED**

Takeshi SHIMIZU

**JUL 28 2005**

Appln. No.: 10/633,716

Group Art Unit: 1756

Confirmation No.: 5699

Examiner: Christopher G. Young

Filed: August 05, 2003

For: METHOD FOR MEASURING GAP BETWEEN MASK AND SUBSTRATE OF  
DISPLAY PANEL

**INFORMATION DISCLOSURE STATEMENT**  
**UNDER 37 C.F.R. §§ 1.97 and 1.98**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure under 37 C.F.R. § 1.56, Applicant hereby notifies the U.S. Patent and Trademark Office of the documents which are listed on the attached PTO/SB/08 A & B (modified) form and/or listed herein and which the Examiner may deem material to patentability of the claims of the above-identified application.

One copy of each of the listed documents is submitted herewith.

The present Information Disclosure Statement is being filed after the later of three months from the application's filing date and the mailing date of the first Office Action on the merits, but before a Final Office Action, Notice of Allowance, or an action that otherwise closes prosecution in the application (whichever is earlier), and therefore Applicant is filing

**INFORMATION DISCLOSURE STATEMENT**  
**U.S. Appln. No. 10/633,716:**

**Attorney Docket No.: Q76777**

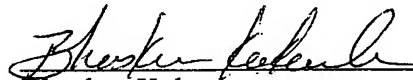
concurrently herewith a Statement Under 37 C.F.R. § 1.97(e). No fee under 37 C.F.R. § 1.17(p) is required.

In compliance with the concise explanation requirement under 37 C.F.R. § 1.98(a)(3) for foreign language documents, Applicant encloses herewith a copy of a Communication from a foreign patent office in a counterpart application citing such documents, together with an English-language version of the Communication indicating the degree of relevance found by the foreign patent office.

The submission of the listed documents is not intended as an admission that any such document constitutes prior art against the claims of the present application. Applicant does not waive any right to take any action that would be appropriate to antedate or otherwise remove any listed document as a competent reference against the claims of the present application.

The USPTO is directed and authorized to charge all required fees, except for the Issue Fee and the Publication Fee, to Deposit Account No. 19-4880. Please also credit any overpayments to said Deposit Account. A duplicate copy of this paper is attached.

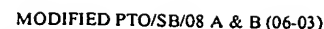
Respectfully submitted,

  
Bhaskar Kakarla  
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SUGHRUE MION, PLLC  
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**23373**  
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Date: July 28, 2005



Substitute for Form 1449 A &amp; B/PTO

*(use as many sheets as necessary)*

*Complete if Known*

Application Number	10/633,716
Confirmation Number	5699
Filing Date	August 05, 2003
First Named Inventor	Takeshi SHIMIZU
Art Unit	1756
Examiner Name	Christopher G. Young
Attorney Docket Number	Q76787

Sheet	1	of	1
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## U.S. PATENT DOCUMENTS

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## FOREIGN PATENT DOCUMENTS

[illegible]

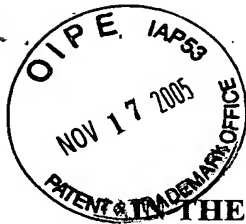
## NON PATENT LITERATURE DOCUMENTS

[illegible]

**Examiner Signature**

**Date Considered**

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kind Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov), MPEP 901.04 or in the comment box of this document. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST. 3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Applicant is to indicate here if English language Translation is attached.



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**STATEMENT UNDER 37 C.F.R. § 1.97(e)**

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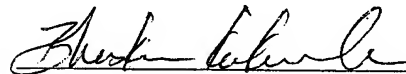
Sir:

The undersigned hereby states, upon information and belief:

That each item of information contained in the Information Disclosure Statement filed concurrently herewith was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of said Information Disclosure Statement.

Respectfully submitted,

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Bhaskar Kakarla  
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